

Search Notes**Application/Control No.**

10/540,973

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	4	3/13/2008	SP
716	1	3/13/2008	SP
257	347,611	3/13/2008	SP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	1, 4	3/13/2008	SP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB	3/13/2008	SP